

|                                   |                                       |   |             |
|-----------------------------------|---------------------------------------|---|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/712,748 | Applicant(s)/Patent Under<br>Reexamination<br>CHAN ET AL. |             |
|                                   | Examiner<br>John B. Walsh             | Art Unit<br>2151  | Page 1 of 1 |

**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name              | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,965,302                                     | 11-2005         | Mollenkopf et al. | 375/259        |
| * | B | US-6,958,680                                     | 10-2005         | Kline, Paul A.    | 340/310.11     |
| * | C | US-6,947,409                                     | 09-2005         | Iwamura, Ryuichi  | 370/345        |
| * | D | US-6,904,134                                     | 06-2005         | Jeon et al.       | 379/93.07      |
| * | E | US-6,885,674                                     | 04-2005         | Hunt et al.       | 370/420        |
| * | F | US-6,243,413                                     | 06-2001         | Beukema, Troy J.  | 375/222        |
| * | G | US-6,130,896                                     | 10-2000         | Lueker et al.     | 370/469        |
|   | H | US-  |                 |                   |                |
|   | I | US-  |                 |                   |                |
|   | J | US-  |                 |                   |                |
|   | K | US-  |                 |                   |                |
|   | L | US-  |                 |                   |                |
|   | M | US-  |                 |                   |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | O |  |                 |         |      |                |
|   | P |  |                 |         |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U |   |
|   | V |   |
|   | W |   |
|   | X |   |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.